

THERMAL RESISTANCE RATINGS								
Parameter	Symbol	Typical	Maximum	Unit				
Maximum Junction-to-Ambient (MOSFET) <sup>b, d</sup>	t ≤ 5 s	$R_{thJA}$	51	62.5				
Maximum Junction-to-Foot (Drain) (MOSFET)	Steady State	$R_{thJF}$	30	37	°C/W			
Maximum Junction-to-Ambient (Schottky)b, e	t ≤ 5 s	$R_{thJA}$	73	90	C/VV			
Maximum Junction-to-Foot (Drain) (Schottky)	Steady State	$R_{thJF}$	50	65				

- Notes: a. Based on  $T_C$  = 25 °C. b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under Steady State conditions is 105 °C/W.
  e. Maximum under Steady State conditions is 125 °C/W.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	-				l.	L
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V, I}_{D} = -250 \mu\text{A}$	- 20			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A		- 20		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I <sub>D</sub> = - 250 μA		3		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.6		- 1.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 1 - 10	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le 5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 8			Α
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -3.5 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -3.0 \text{ A}$		0.058 0.085	0.070 0.105	Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 3.5 A		10		S
Dynamic <sup>b</sup>	1					I.
Input Capacitance	C <sub>iss</sub>			480		pF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		132		
Reverse Transfer Capacitance	C <sub>rss</sub>			55		
Total Gate Charge	$Q_{g}$	$V_{DS} = -10 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -5.0 \text{ A}$		9.7	14.5	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 4.5 A		4.5 1.0	7	nC
Gate-Drain Charge	Q <sub>gd</sub>			1.0		
Gate Resistance	R <sub>g</sub>	f = 1 MHz		7.5		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			6	10	
Rise Time	t <sub>r</sub>	$V_{DD} = -10 \text{ V}, R_1 = 2.0 \Omega$		54	85	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -5.0 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		19	30	
Fall Time	t <sub>f</sub>			8	15	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = - 10 V, $R_L$ = 2.0 $\Omega$ $I_D \cong -5.0$ A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		26	40	ns
Rise Time	ì,			80	120	1
Turn-Off DelayTime	t <sub>d(off)</sub>			20	30	
Fall Time	t <sub>f</sub>			10	15	





## Si3879DV Vishay Siliconix

<b>SPECIFICATIONS</b> $T_J = 25  ^{\circ}\text{C}$ , unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 2.7	A	
Pulse Diode Forward Current	I <sub>SM</sub>				- 20		
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 1.0 A, V <sub>GS</sub> = 0 V		- 0.75	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = - 3.5 A, dI/dt = 100 A/μs, T <sub>J</sub> = 25 °C		25	40	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			12	20	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			9		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			16			

#### Notes:

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

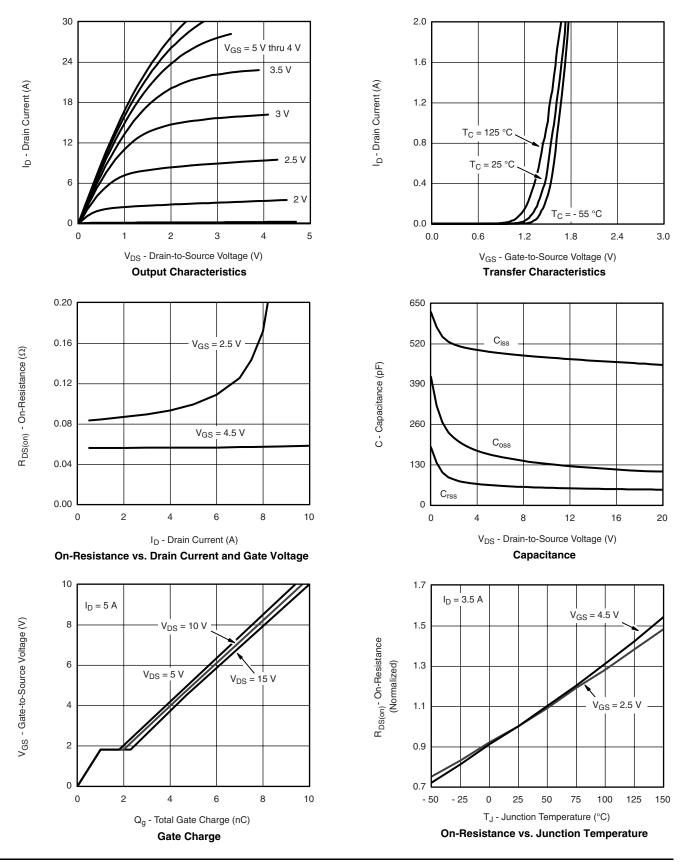
b. Guaranteed by design, not subject to production testing.

SCHOTTKY SPECIFICATIONS						
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Forward Voltage Drop	V <sub>F</sub>	I <sub>F</sub> = 1 A		0.41	0.45	V
		I <sub>F</sub> = 1 A, T <sub>J</sub> = 125 °C		0.36	0.41	
Maximum Reverse Leakage Current	I <sub>rm</sub>	V <sub>R</sub> = 5 V		0.015	0.08	mA
		V <sub>R</sub> = 5 V, T <sub>J</sub> = 85 °C		0.50	5.00	
		V <sub>R</sub> = 20 V		0.02	0.10	
		V <sub>R</sub> = 20 V, T <sub>J</sub> = 85 °C		0.7	7.00	
		V <sub>R</sub> = 20 V, T <sub>J</sub> = 125 °C		5	50	
Junction Capacitance	C <sub>T</sub>	V <sub>R</sub> = 10 V		60		pF

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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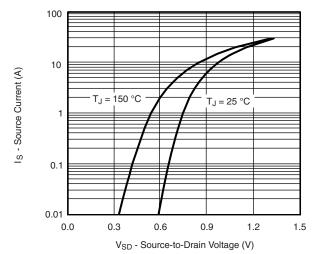
#### **MOSFET TYPICAL CHARACTERISTICS** $T_A = 25~^{\circ}\text{C}$ , unless otherwise noted



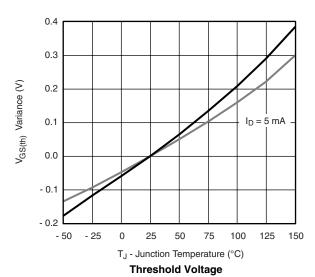


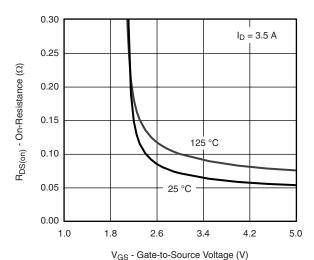


#### **MOSFET TYPICAL CHARACTERISTICS** $T_A = 25$ °C, unless otherwise noted

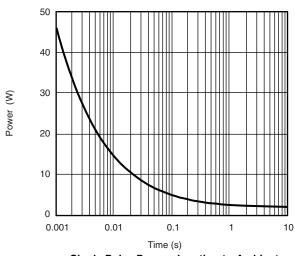


#### Soure-Drain Diode Forward Voltage

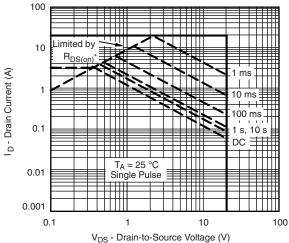




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

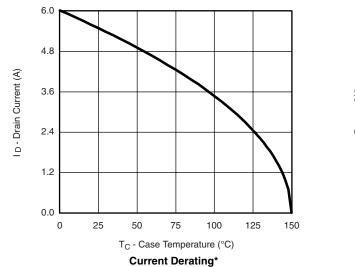


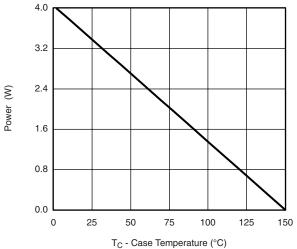
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Case

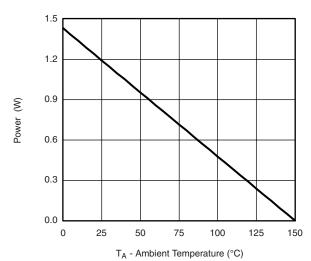
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#### **MOSFET TYPICAL CHARACTERISTICS** $T_A = 25$ °C, unless otherwise noted





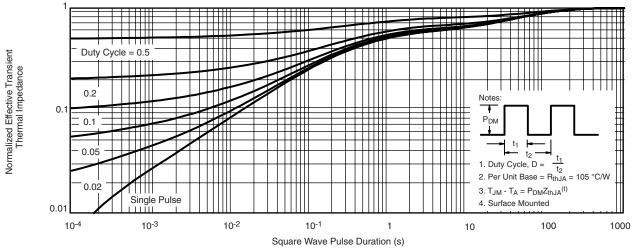
Power Derating, Junction-to-Foot



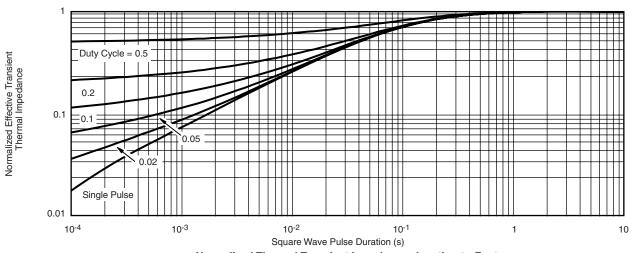
Power Derating, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

#### **MOSFET TYPICAL CHARACTERISTICS** $T_A = 25$ °C, unless otherwise noted



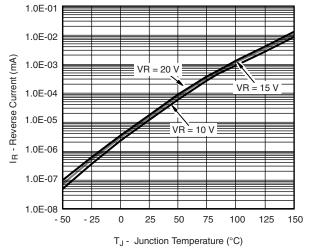
#### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

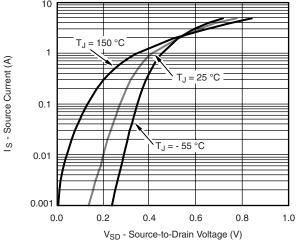
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### SCHOTTKY TYPICAL CHARACTERISTICS $T_A = 25~^{\circ}C$ , unless otherwise noted

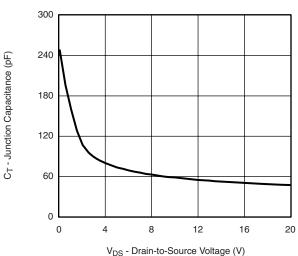


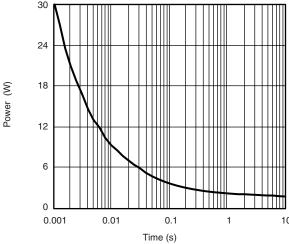
**Reverse Current vs. Junction Temperature** 

Capacitance



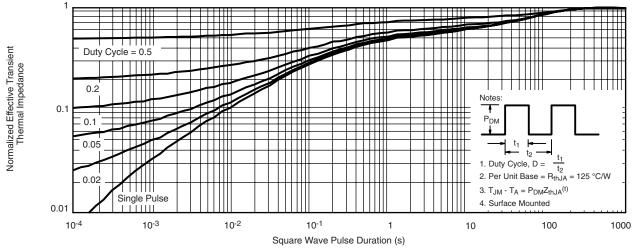
Forward Diode Voltage



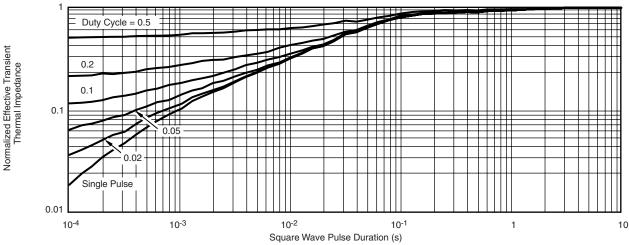


Single Pulse Power, Junction-to-Ambient

#### SCHOTTKY TYPICAL CHARACTERISTICS $T_A = 25~^{\circ}C$ , unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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